Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/796,542	TAKEWAKI ET AL.
Examiner	Art Unit
David Sample	1755

	SEARCHED				
Class	Subclass	Date	Examiner		
423	Dig.27	4/12/2005	GHI .		
423	700	4/12/2005	QUI		
210	691	4/12/2005	PMI		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
SAME A	S ABOVE	4/12/2005	PM	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Inventor name search	4/12/2005	GU 1		
Parent applications reviewed included prior art cited therein	4/12/2005	<i>QUI</i>		